

Search Notes**Application/Control No.**

10/654,343

Examiner

Rick K. Chang

Applicant(s)/Patent under Reexamination

NAKATANI ET AL.

Art Unit

3729

SEARCHED

Class	Subclass	Date	Examiner
29	832,83584 1,739,740	2/3/2006	RC
228	110.1		
156	48		
174	52.2-52.4		
310	312,340		
	346,344		
	348,313R		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
reviewed parent case and references cited therein	2/3/2006	RC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner